TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $L^2$ - $\pi$ -MOSV)

# 2SK2173

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

• 4-V gate drive

• Low drain-source ON resistance  $: R_{DS(ON)} = 13 \text{ m}\Omega \text{ (typ.)}$ 

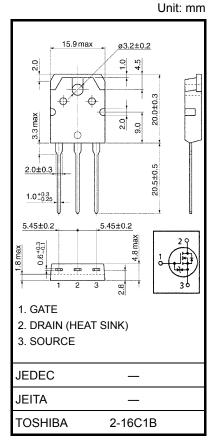
 $\bullet \quad \mbox{High forward transfer admittance} \quad \mbox{:} \; |\,Y_{fs}\,| \, = 40\; S \; (\mbox{typ.})$ 

• Low leakage current :  $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 60 \text{ V)}$ 

• Enhancement mode :  $V_{th} = 0.8 \sim 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

#### **Absolute Maximum Ratings (Ta = 25°C)**

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	60	V	
Drain-gate voltage (R	<sub>GS</sub> = 20 kΩ)	$V_{DGR}$	60	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	ID	50	Α	
	Pulse (Note 1)	I <sub>DP</sub>	200	Α	
Drain power dissipatio	n (Tc = 25°C)	P <sub>D</sub>	125	W	
Single pulse avalanche	e energy (Note 2)	E <sub>AS</sub>	683	mJ	
Avalanche current		I <sub>AR</sub>	50	Α	
Repetitive avalanche	energy (Note 3)	E <sub>AR</sub>	12.5	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature r	ange	T <sub>stg</sub>	-55~150	°C	



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.0	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 25 V,  $T_{ch}$  = 25°C (initial), L = 371  $\mu$ H,  $R_{G}$  = 25  $\Omega$ ,  $I_{AR}$  = 50 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



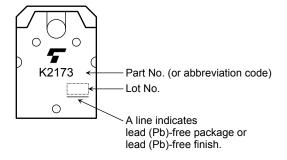
### **Electrical Characteristics (Ta = 25°C)**

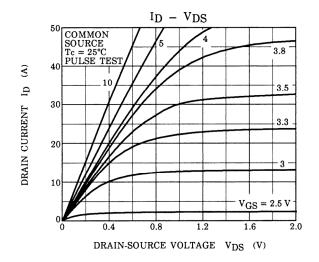
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Drain cut-off cur	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	60	_	_	V
Gate threshold v	oltage/	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	8.0	_	2.0	V
Duning and an ON provinted as		R <sub>DS (ON)</sub>	V <sub>GS</sub> = 4 V, I <sub>D</sub> = 25 A	_	19	25	
Drain-source ON resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 25 A		_	13	17	mΩ	
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 25 A	28	40	_	S
Input capacitano	e	C <sub>iss</sub>		_	3550	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	550	_	pF
Output capacitance		Coss		_	1600	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS} = 10V$	_	25	_	- ns
	Turn-on time	t <sub>on</sub>		_	55	_	
	Fall time	t <sub>f</sub>		_	60	_	
	Turn-off time	t <sub>off</sub>	$V_{DD} = 30V$ Duty $\leq 1\%$ , $t_W = 10 \mu s$	_	180	_	
Total gate charge (Gate-source plus gate-drain)		Qg		-	110	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 48 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$		70		nC
Gate-drain ("miller") charge		Q <sub>gd</sub>			40	_	

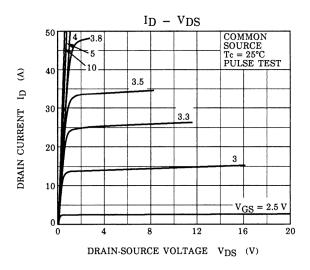
## Source-Drain Ratings and Characteristics (Ta = 25°C)

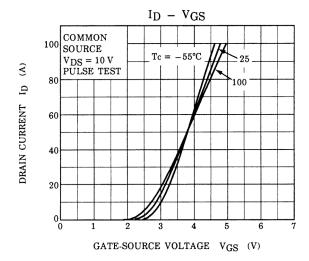
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	50	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	200	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 50 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 50 A, V <sub>GS</sub> = 0 V	1	120	_	ns
Reverse recovered charge	Qrr	$dI_{DR}$ / $dt = 50 A / \mu s$	_	0.2	_	μC

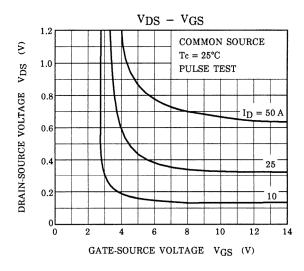
### Marking

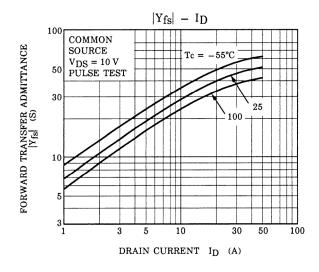


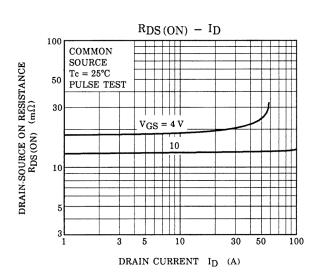




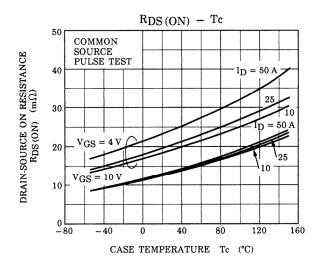


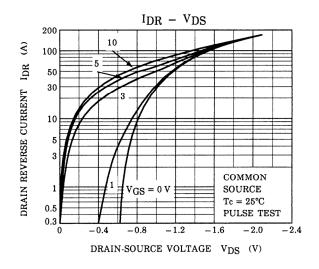


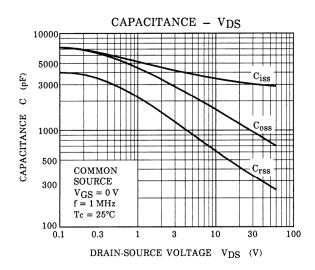


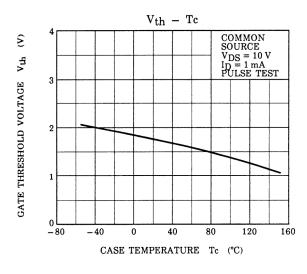


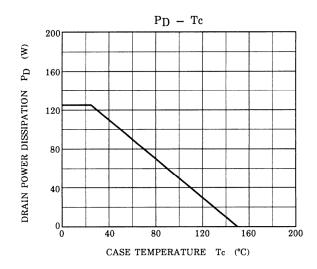
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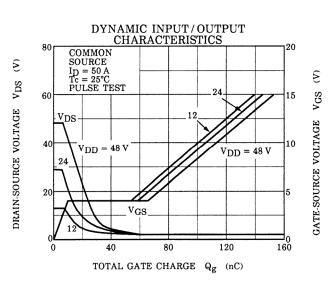


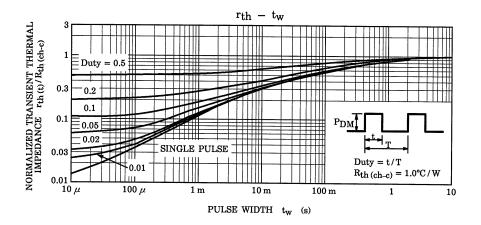


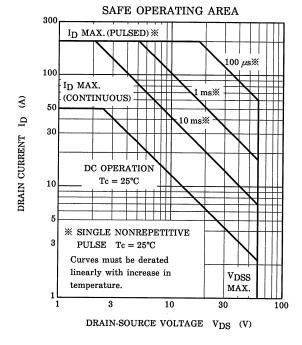


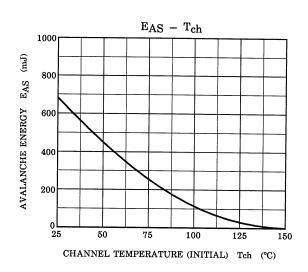


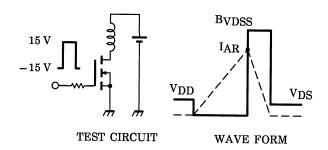












$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 25~V,~L = 371~\mu H \end{aligned} \qquad E_{AS} &= \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BV_{DSS}}{BV_{DSS} - V_{DD}} \right) \end{aligned}$$

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